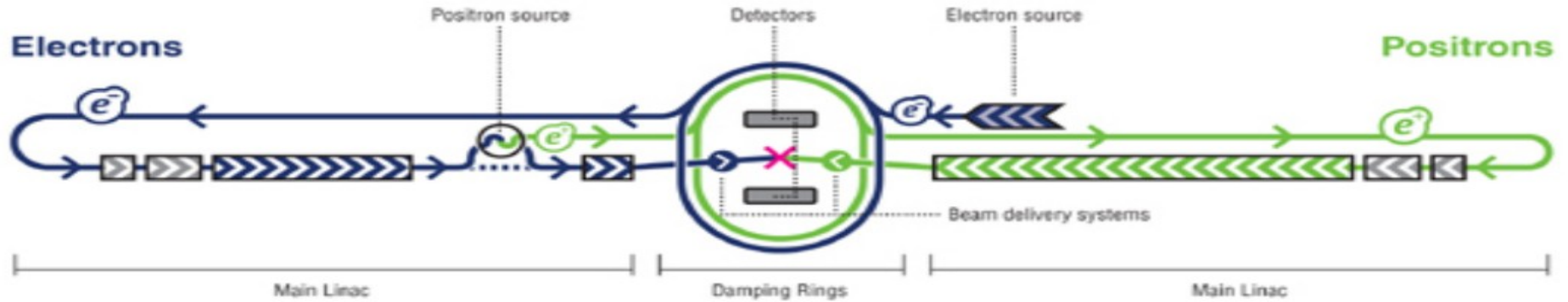

ILD vertex detector & CMOS sensors studies

Yorgos Voutsinas
on behalf of IPHC Strasbourg

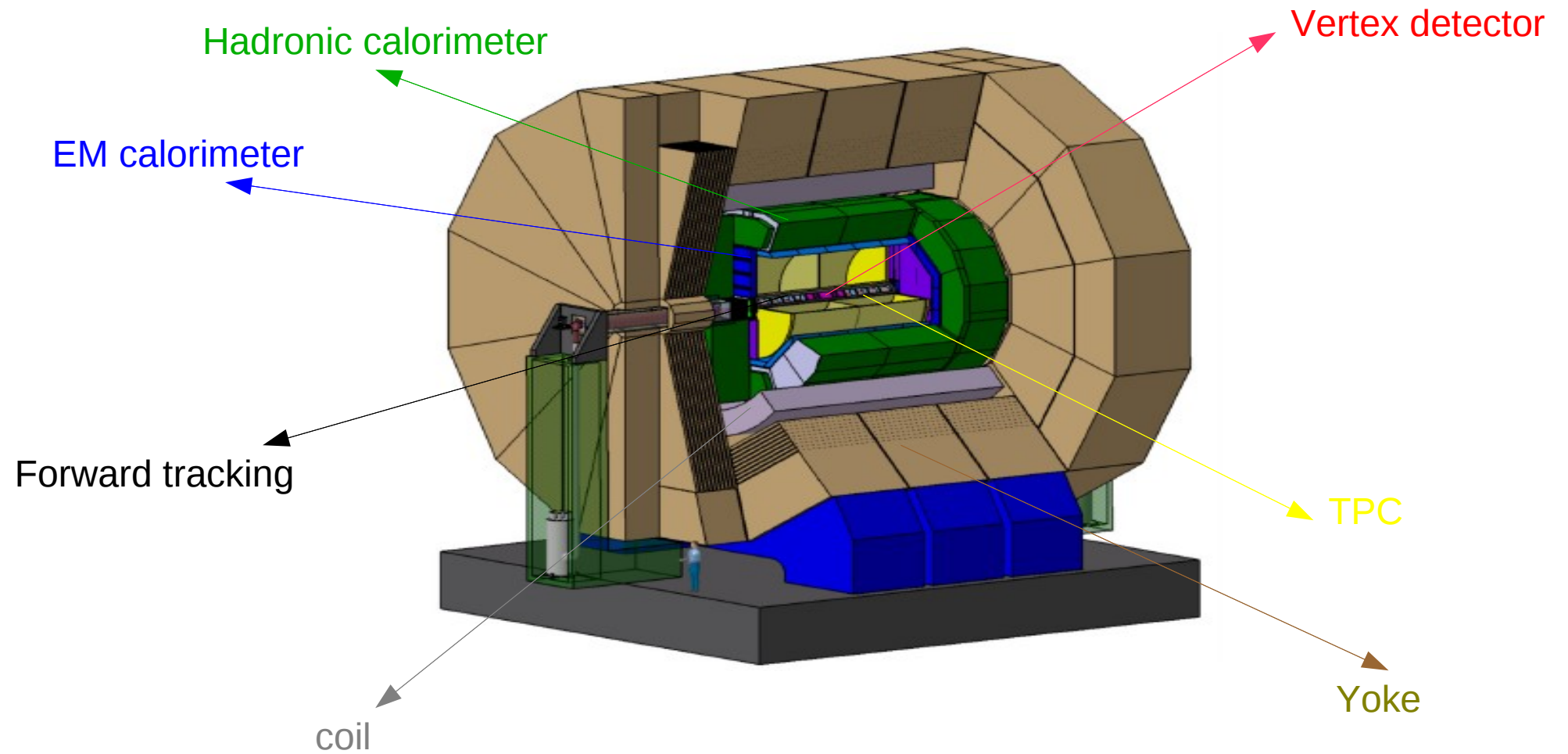
- International Linear Collider
- ILD vertex detector
- CMOS sensors
 - Beam test data analysis
 - CMOS based vertex detector for ILC
- Vertex detector optimisation studies

International Linear Collider



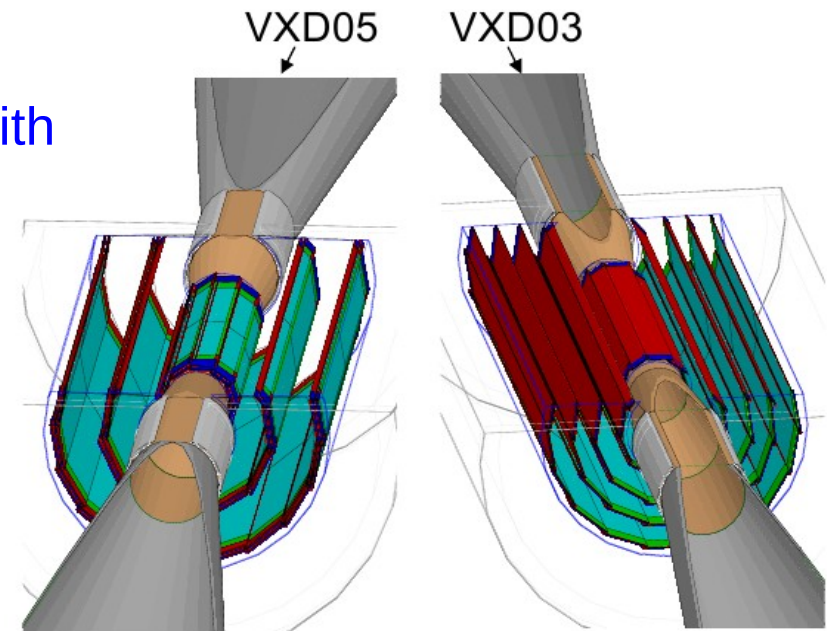
- Future linear electron – positron collider
 - $\sqrt{s} = 500\text{GeV}$, option for 1TeV
 - High precision machine
 - ✓ Well defined initial state
 - ✓ Clean final state
 - ✓ Triggerless
 - Complementary to LHC
- 2 general purpose detectors
 - SiD
 - ILD

ILD

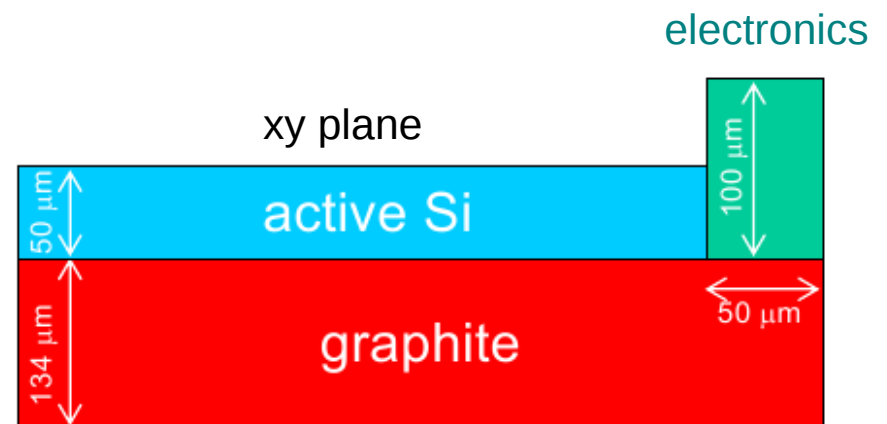


ILD vertex detector

- 2 main candidate geometries for ILD VXD
 - VXD05: with 3 double layers equipped with silicon pixel sensors
 - VXD03: 5 single layers



	VXD03	VXD05
layers	5	3 x 2
sensitive length (mm)	62.5	125
sensitive width (mm)	11-15-22	11-22
radii (mm)	15-60	16-60
sensitive thickness (μm/ladder)	50	50
graphite insensitive thickness (μm/ladder)	134	134



Beam induced background

- Background induced due to beam-beam interaction
 - When the beams approaching, exert force to each other
 - Particle's trajectories are bent – beam spot is reduced (pinch effect)
 - ➔ Luminosity enhancement by a factor ~ 2
 - ➔ Emission of hard beamstrahlung γ
 - × beam energy degradation
 - × A part of γ is converted to low energy e^+e^- pairs ($\sim 10^5$ per BX)
- Pairs main source of background to ILC detectors
- Vast majority of pairs are low momentum particles emitted at the very forward direction
- Still some with higher P_T or other backscattered at beamcal can reach VXD

layer	VTX-DL	VTX-SL
1	4.4 ± 0.5	5.3 ± 0.5
2	2.9 ± 0.4	$6.0 \pm 0.5 \times 10^{-1}$
3	$1.54 \pm 0.14 \times 10^{-1}$	$1.9 \pm 0.13 \times 10^{-1}$
4	$1.34 \pm 0.11 \times 10^{-1}$	$6.9 \pm 0.6 \times 10^{-2}$
5	$3.2 \pm 0.7 \times 10^{-2}$	$3.1 \pm 0.4 \times 10^{-2}$
6	$2.7 \pm 0.5 \times 10^{-2}$	

Hit densities from pair background / BX cm^2
from R. DeMasi ILC note

ILD vertex detector requirements

- Figure of merit Impact parameter resolution

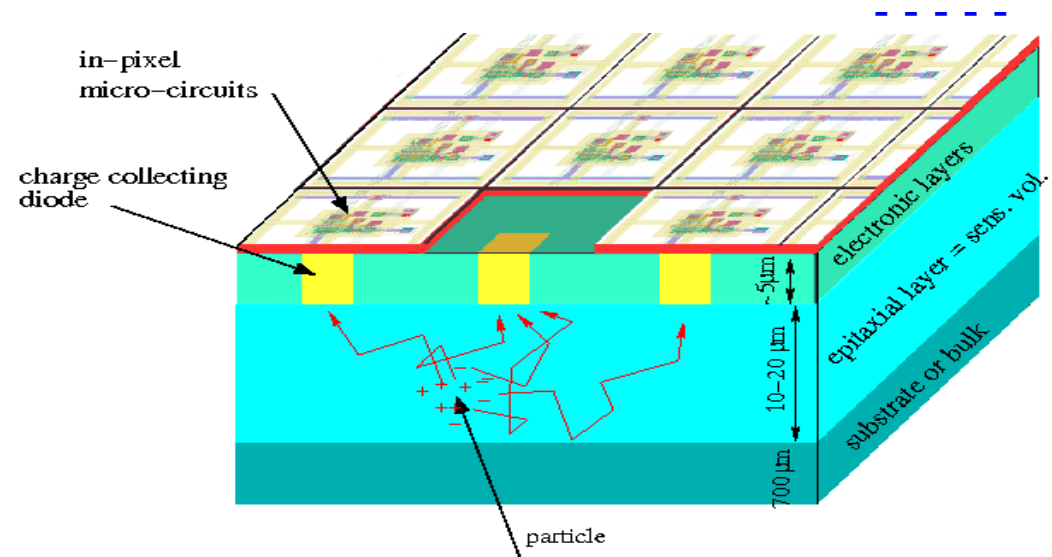
$$\sigma_{IP} = a \oplus b/p \sin^{3/2} \theta$$

$a \leq 5 \mu\text{m}, b \leq 10 \mu\text{m GeV}$

- Sensor's single point resolution $\sim 3 \mu\text{m}$
- Material budget $> 0.2\% X_0$ per layer
- Power dissipation $< 100\text{W}$
- Running constraints mostly defined from beam induced e^-e^+ pair background
 - Determines pixel occupancy
 - ➔ Require a relative fast readout
 - ➔ $25 \mu\text{s}$ for inner layers, $100 \mu\text{s}$ for outer
 - Moderate radiation tolerance
 - ➔ 0.3MRad/y , few $10^{11} n_{eq} / \text{cm}^2 \text{ y}$
- CMOS sensors is a promising candidate technology

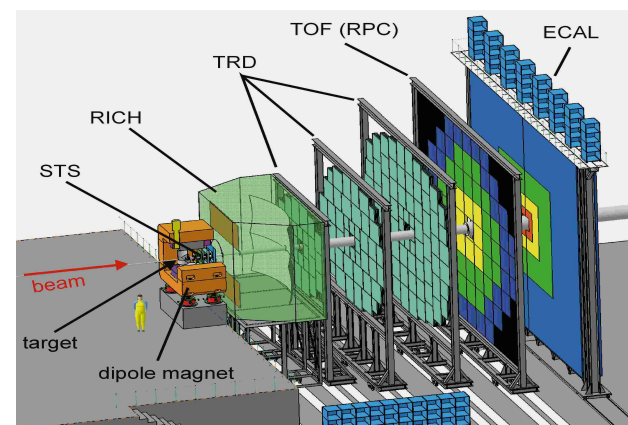
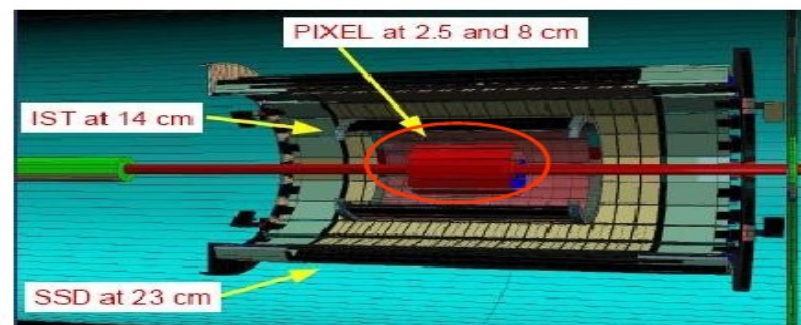
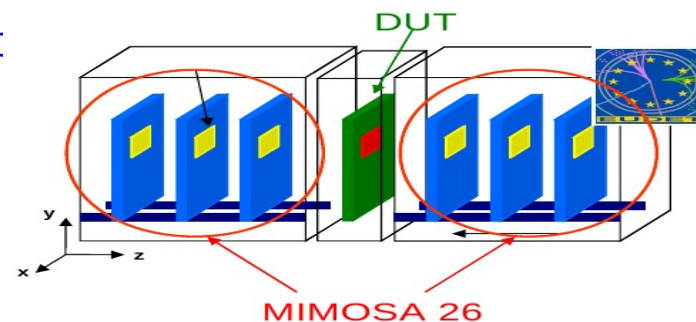
CMOS sensors principle of operation – main features

- CMOS sensors: Appropriate technology for high precision tracking devices like vertex detectors and beam telescopes
- Signal created by mips: $\sim 80e^-h$ pairs/ μm
- Electrons diffuse thermally at epi layer collected by an Nwell-p-epi junction
- Advantages
 - ✓ High granularity $O(10\mu m)$
 - ✓ Low material budget ($< 50\mu m$)
 - ✓ Signal processing on substrate
 - ✓ Cost
- Limitations
 - ✓ Small signal $O(1000e^-)$ calls for low noise electronics
 - ✓ Use of only NMOS transistors for on pixel signal processing
 - ✓ Undepleted sensitive volume \rightarrow non ionising radiation tolerance, charge collection



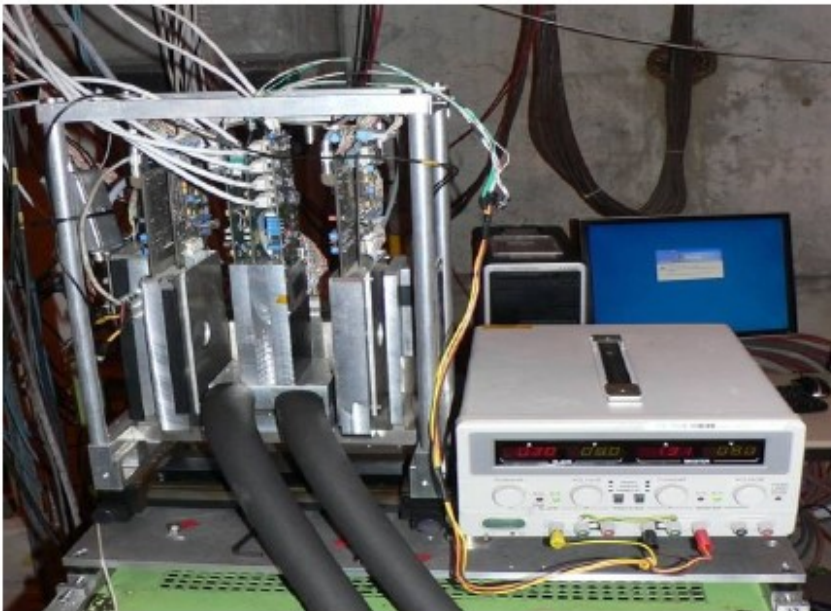
CMOS sensors HEP applications

- MIMOSA26 first real scale digital sensor of this series with on chip data sparsification
- MIMOSA 26 equips reference planes of EUDET beam telescope
 - EUDET FP6 project - infrastructure for ILC detectors R&D
 - Commissioned at CERN SPS at 2009
 - Extrapolated resolution $\sim 2\mu\text{m}$
 - Upto 10^6 particles/cm²/s beam intensity
- Baseline sensor for heavy ion collider experiments
 - STAR HFT
 - ✓ 1M pixels
 - ✓ 200 μs integration time
 - ✓ First data expected at 2013
 - CBM MVD
 - ✓ More severe radiation tolerance requirements
 - ✓ Double sided ro (20 μs int. time)
 - ✓ Prototyping 2012
- ILD vertex detector (option)
- ALICE upgrade (option)



CMOS sensors test beam data analysis

- Main goals of a beam test
 - Analog part: measure charge collection, noise, signal/noise ratio
 - Digital part: calculate efficiency, resolution, fake hit rate, cluster multiplicity
 - Radiation tolerance studies with sensors irradiated with ionising or/and non ionising radiation
- Use of a beam telescope for track reconstruction



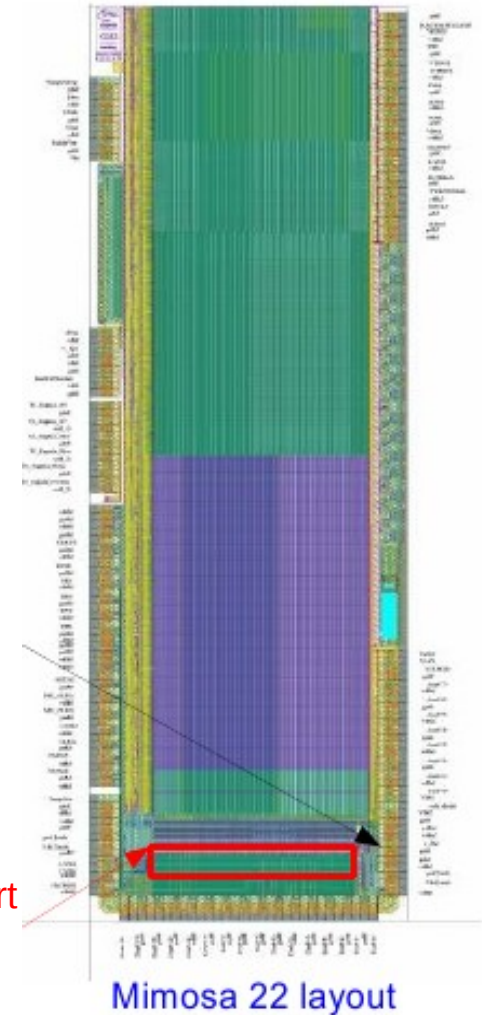
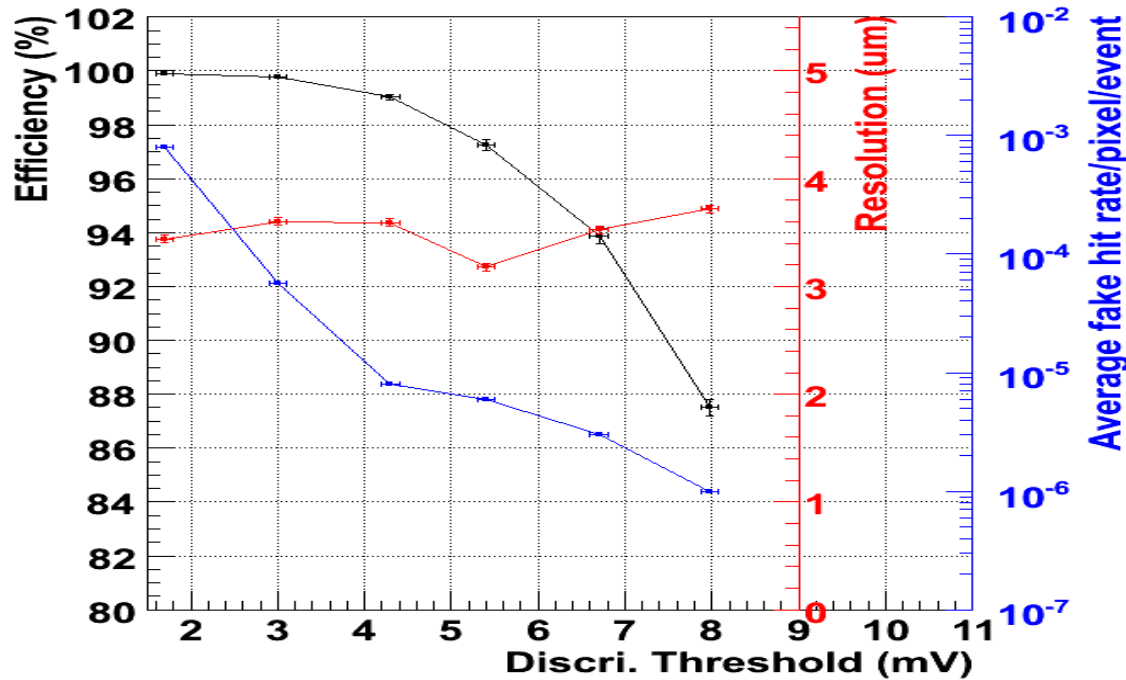
- Following results are from beam tests at CERN SPS
- 120GeV pion beam – multiple scattering negligible

MIMOSA 22/22bis beam test analysis

- Intermediate digital sensor for EUDET beam telescope
 - Column parallel readout mode at a real scale sensor
 - Optimization of pixel architecture for EUDET BT sensor
 - Radiation tolerance studies

Mimosa 22bis non irr.	2.48M
Mimosa 22bis 150krad(20 & 35°C)	2.17M
Mimosa 22bis 300krad	660k
Mimosa 22 $10^{12} n_{eq}$	1M

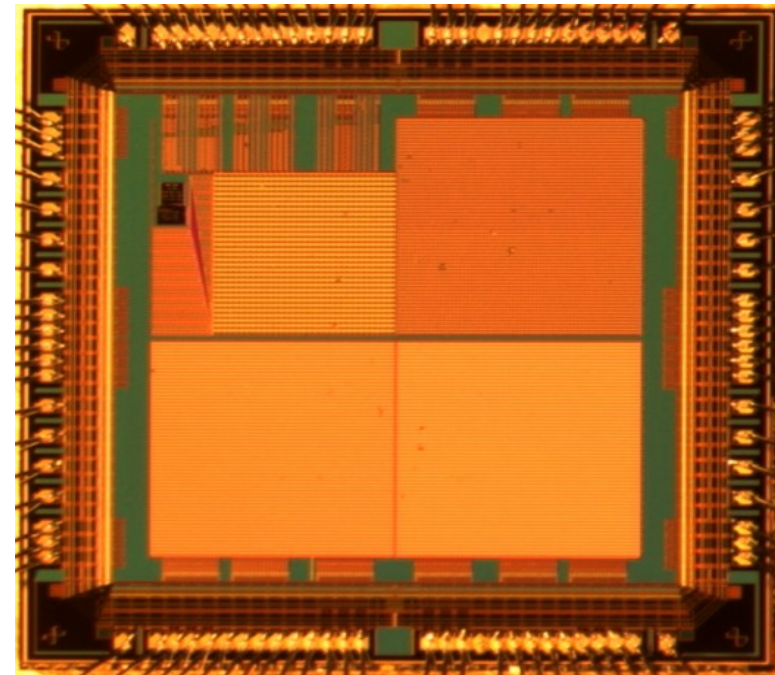
M22bis digital S5. Efficiency, Fake rate and Resolution



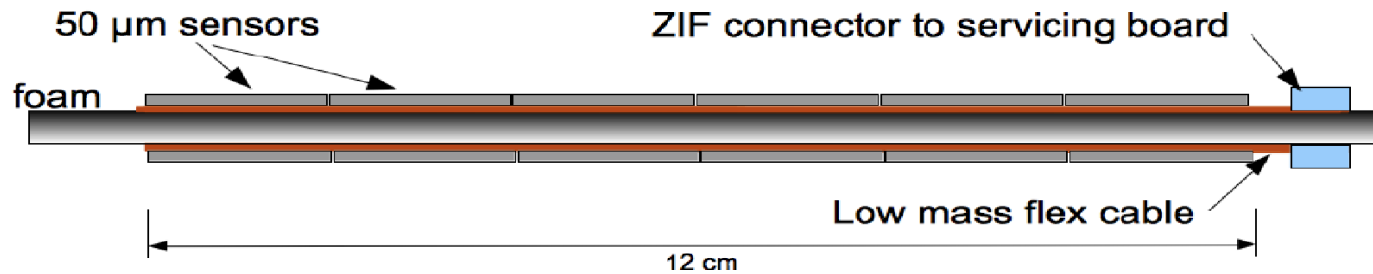
- For not irradiated chips @ 20°C
 - Efficiency ~ 99.8% for fake rate per pixel $O(10^{-5})$ - Resolution between 3.5 - 4um
- Reference pixel design exhibits satisfactory results in both sensors / EUDET

MIMOSA 24 beam test analysis

- Exploration of fabrication processes is an important R&D line
- Epitaxial layer thickness often not known reliably
- MIMOSA 24 motivation: exploration of XFAB 0.35 μm process
- Sensor description
 - Analog sensor with 8 different pixel designs
- Main objective
 - Comparison with MIMOSA9
 - Similar sensor but fabricated in a different process
- Results
 - Indicate similar performance with MIMOSA 9



Towards a CMOS based vertex detector for ILD (1)

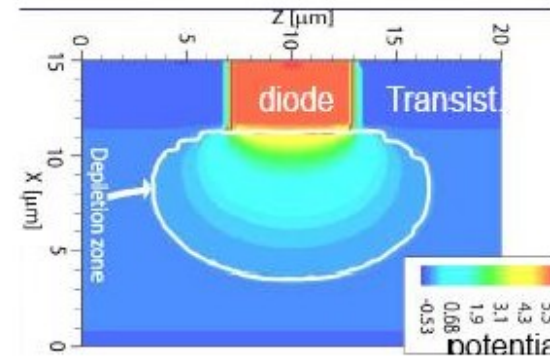


- Sensor integration studies

- PLUME project – collaboration of Bristol - DESY - Oxford – Strasbourg
- Double sided ladder equipped with 2x6 thinned down to 50 μm MIMOSA-26 (material budget 2012 target: 0.3 % X_0)
- Explore feasibility, performances and added value of double-sided ladders

- High resistivity epitaxial layers

- Partially depleted sensitive volume
- More tolerant to non-ionising radiation
- Faster and enhanced charge collection



A.Dorokhov high res. simulation studies

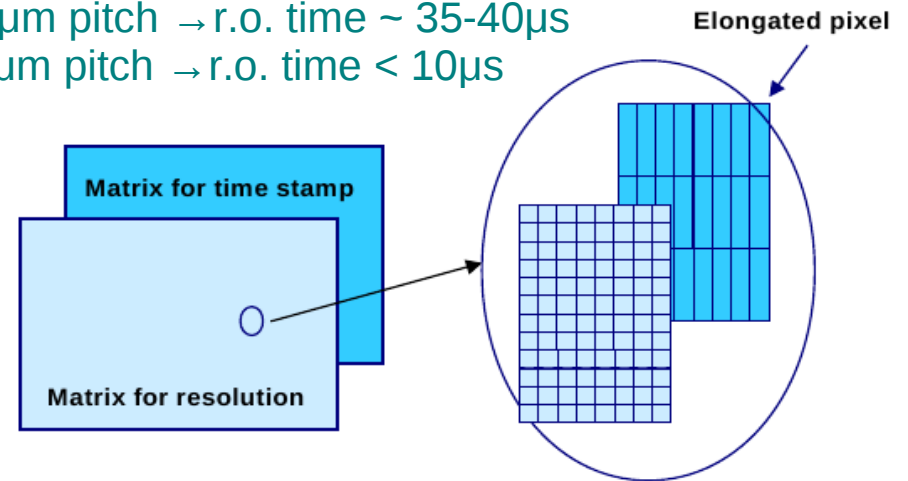
Towards a CMOS based vertex detector for ILD (2)

- Double layers geometry option

- Inner superlayer

- Binary sensors
- First layer ~ 15 μm pitch
 - ✓ High spatial resolution ~ 3 μm
- Second layer ~ 60 μm pitch
 - ✓ Column parallel r/o → r/o time proportional to # pixels/column
 - ✓ Time stamping

- ✓ 15 μm pitch → r.o. time ~ 35-40 μs
- ✓ 60 μm pitch → r.o. time < 10 μs



Depleted epi layer → allows for larger sensing diode spacing

- Outer Layers

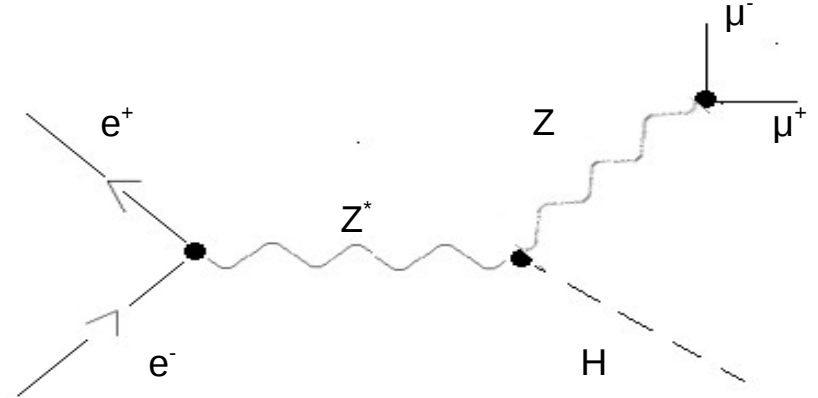
- Less severe requirements @ readout speed
- Pixel pitch ~ 35 μm
- 4-5 bits ADC
 - ✓ Single point resolution < 3.5 μm
- Aim mainly for low power dissipation

ILD vertex detector optimisation

- ILD VXD goals
 - High precision flavour tagging
 - Track reconstruction (especially for low momentum tracks)
- Crucial for
 - Extraction of branching ratios – study of Higgs couplings
 - Vertex charge reconstruction
- Optimisation will be mostly based on
 - Performance of the 2 main candidate VXD geometries on
 - Heavy flavour tagging performance
 - Extraction of Higgs hadronic branching ratios
 - Reconstruction of vertex charge
 - Study of VXD performance in the presence of pair beam background
- ★ No specific sensor technology assumed in these studies

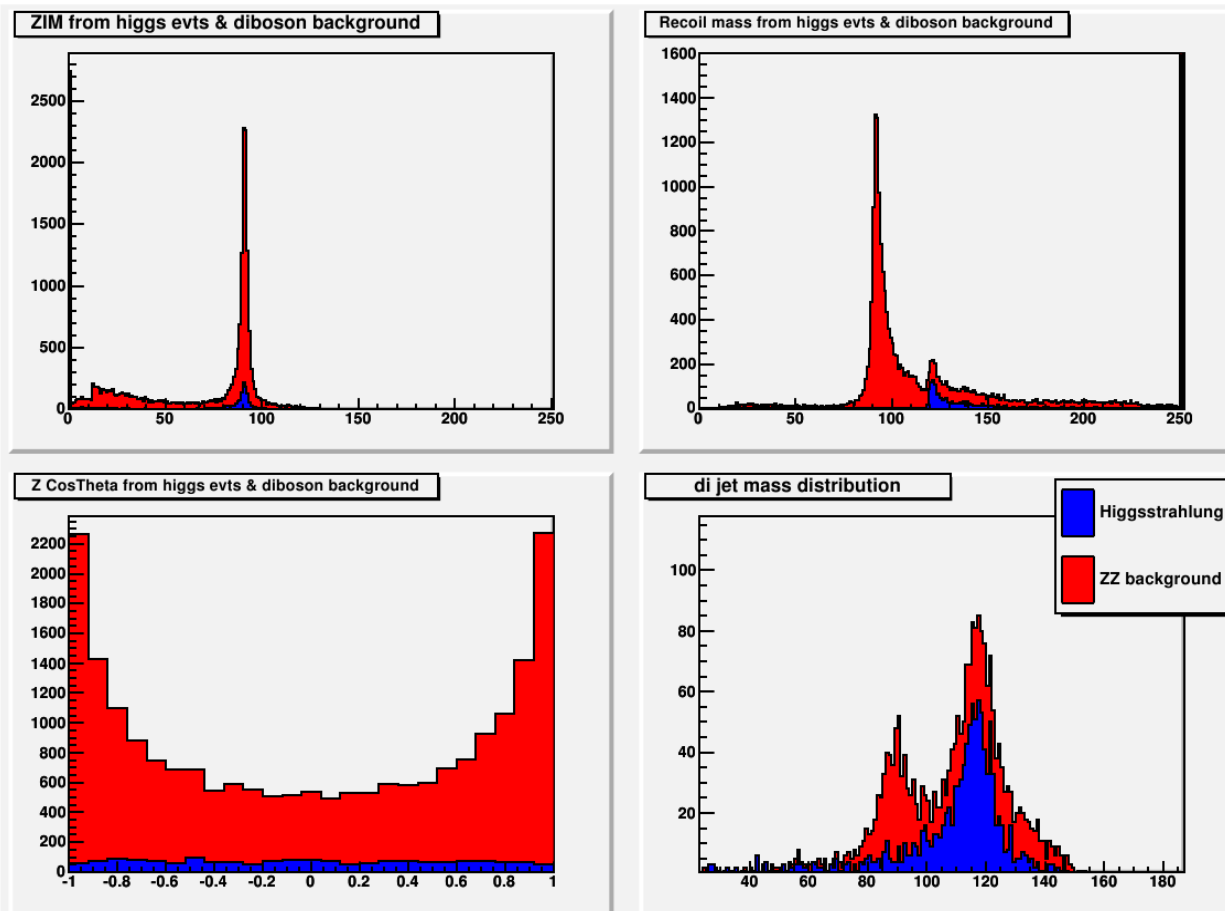
Physics channel – event reconstruction

- Higgsstrahlung channel $e^+e^- \rightarrow ZH \rightarrow \mu^+\mu^-X$
 - \sqrt{s} 250GeV
 - M_H 120GeV
 - Higgs decaying according to its SM BR – Z decaying to a pair of muons
 - Z recon. out of best candidate pair of muons
 - Rest of particles forced to 2 jets, using Durham jet clustering algorithm
- MC file from ILC data samples – unpolarized beams, cross section $\sim 7\text{fb}$
- Simulated with Mokka (Geant4 based package)
 - Exchange VXD models: VXD03 (single layers) & VXD05 (double layers)
 - s.p. Resolution assumed $2.8\mu\text{m}$ for all layers
- 250fb^{-1} reconstructed with ilcsoft
- An independent sample of 500fb^{-1} has been reconstructed to be used at the fit for the BR extraction



Physics background – event selection

- $e^+e^- \rightarrow ZZ \rightarrow \mu^+\mu^-qq_{\text{bar}}$, beam polarization 0, $\sigma = 79.0\text{fb}$
 - 250fb^{-1} events reconstructed
- $e^+e^- \rightarrow WW \rightarrow \mu\nu_{\mu}qq_{\text{bar}}$, beam polarization 0, $\sigma = 2278.55\text{fb}$
 - Out of 10k events reconstructed, 1 event passes the cuts=> assumed negligible
- 2f-4f background negligible



Event selection

- (1) $70\text{GeV} < \text{muon pair IM} < 110\text{GeV}$
- (2) 1 only Z candidate
- (3) $117\text{GeV} < \text{Recoil mass} < 150\text{GeV}$
- (4) $|\cos\theta_z| < 0.9$
- (5) $100\text{GeV} < \text{di-jet IM} < 140\text{GeV}$

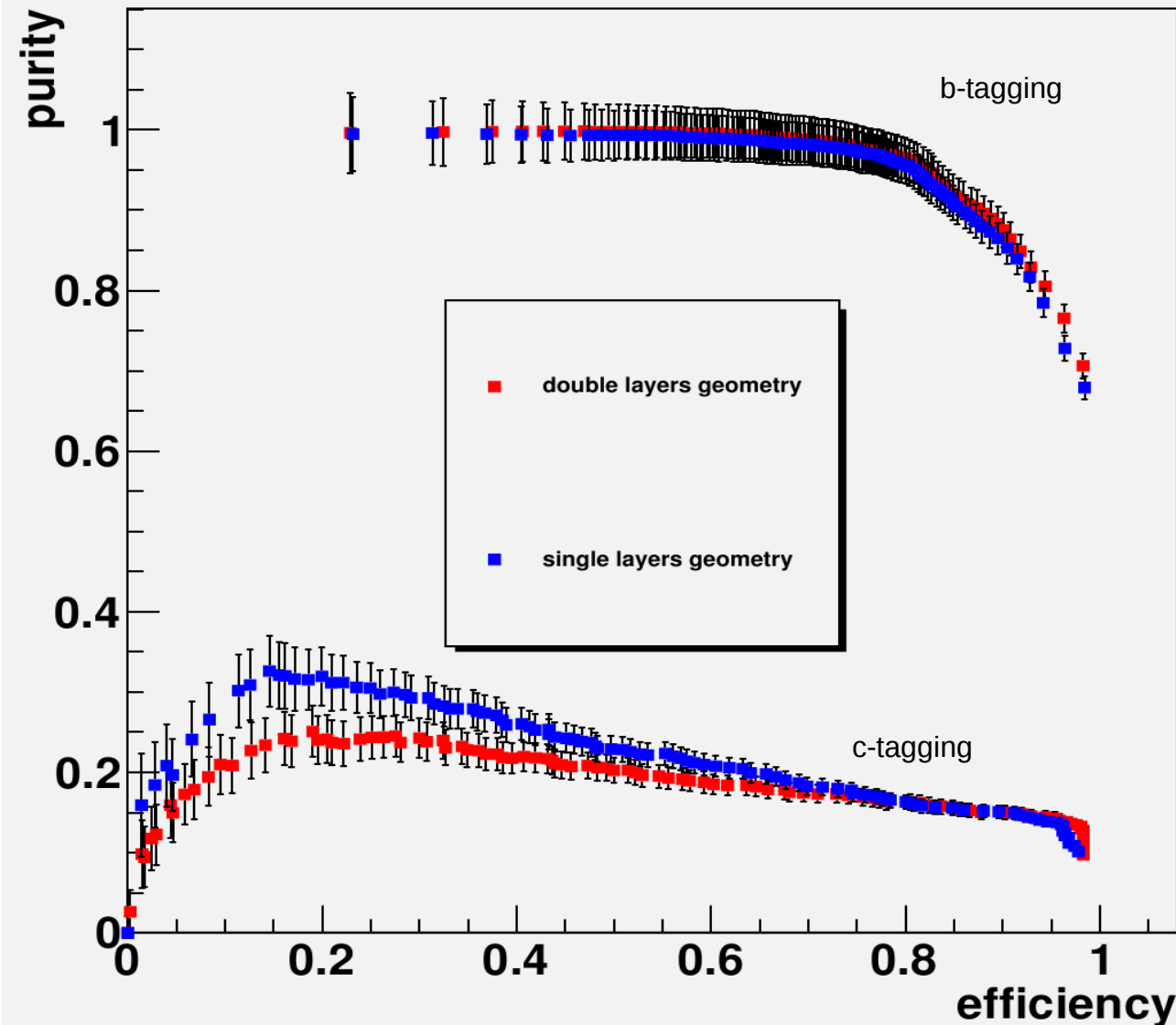
$$S/\sqrt{S+B} = 21.4$$

Neural nets based flavour tagging

- Neural nets of LCFI group used for heavy flavour tagging
- Training sample: $Z \rightarrow qqbar$ @ $\sqrt{s} = 91.2\text{GeV}$, 10k for each different VXD geometry
- 3 different sets of nets for b(c) tagging depending on vertex multiplicity in the jet
- Different set of discriminating variables used for 1 or >1 vertices found
 - Main variables when 1 vertex found inside the jet
 - Impact parameter significance and P_T of the 2 most significant tracks
 - Joint probability that all tracks coming from primary vertex
 - When the jet has 2 or more vertices
 - Mostly use observables from the additional vertices
- Training uncertainties much smaller than statistical
- Neural nets checked for overtraining

Flavour tagging results – no beam bkg

efficiency - purity plots for higgsstrahlung



- 700fb⁻¹ of Higgsstrahlung analyzed
- No beam bkg superimposed
- Statistical errors shown in plot
- Nets uncertainties ~ 1% - less than statisticals
- B tagging performance almost identical
- C tagging performance : single layer option has a region for low and moderate efficiency with higher purity
 - Mainly due to smaller distance from IP

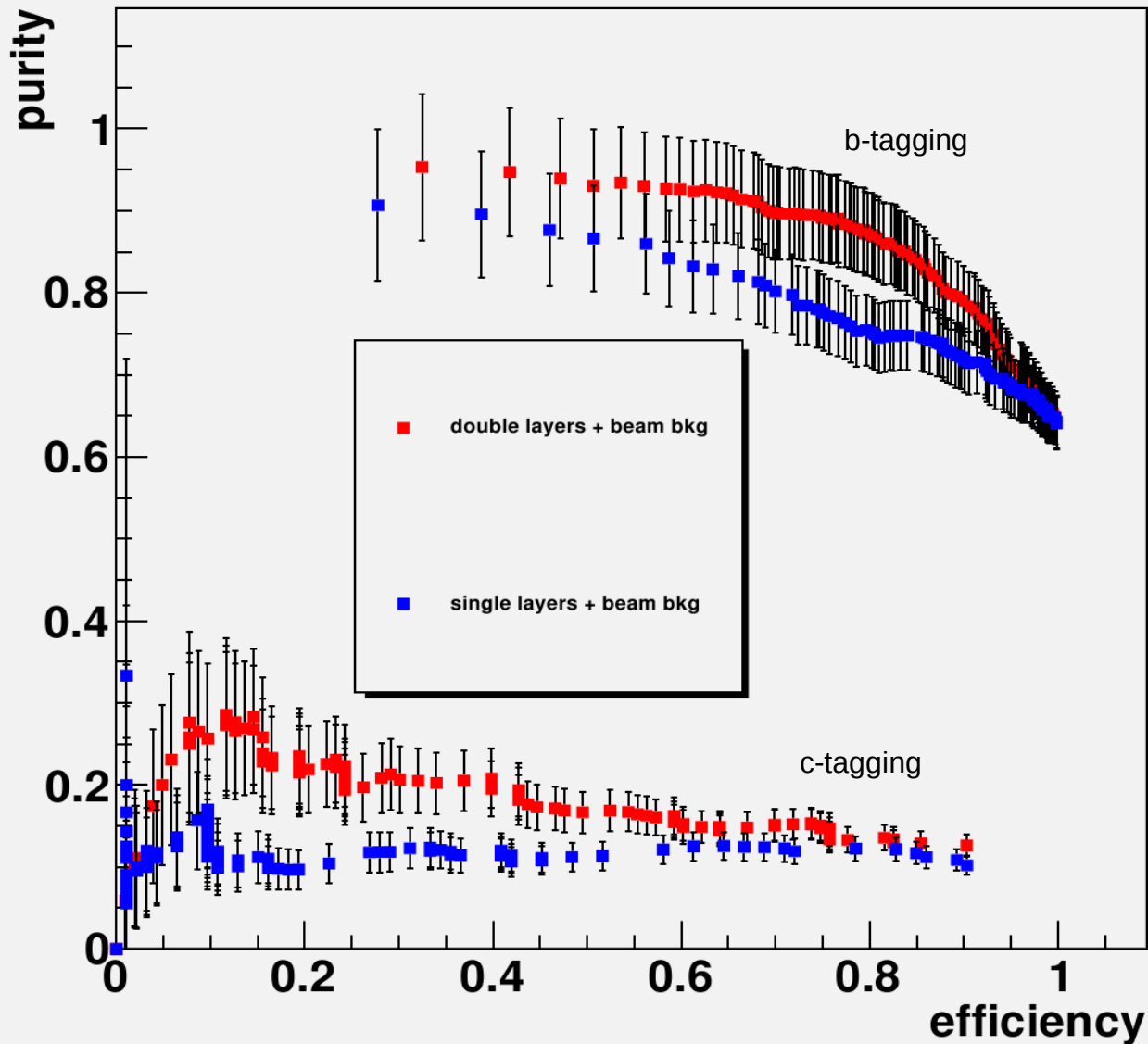
Beam background

- Random noise clusters superimposed according to expected hit density
- Number of BXs superimposed depending to readout time of each VXD layer
 - Pixel occupancy
 - Combinatorial background
 - Fake tracks

layer	Readout (μs) - (#BXs superimposed)	
	SL	DL
0	25 (68)	25 (68)
1	50 (136)	25 (68)
2	100 (272)	100 (272)
3	100 (272)	100 (272)
4	100 (272)	100 (272)
5		100 (272)

Flavour tagging with beamstrahlung

efficiency - purity plots for higgsstrahlung

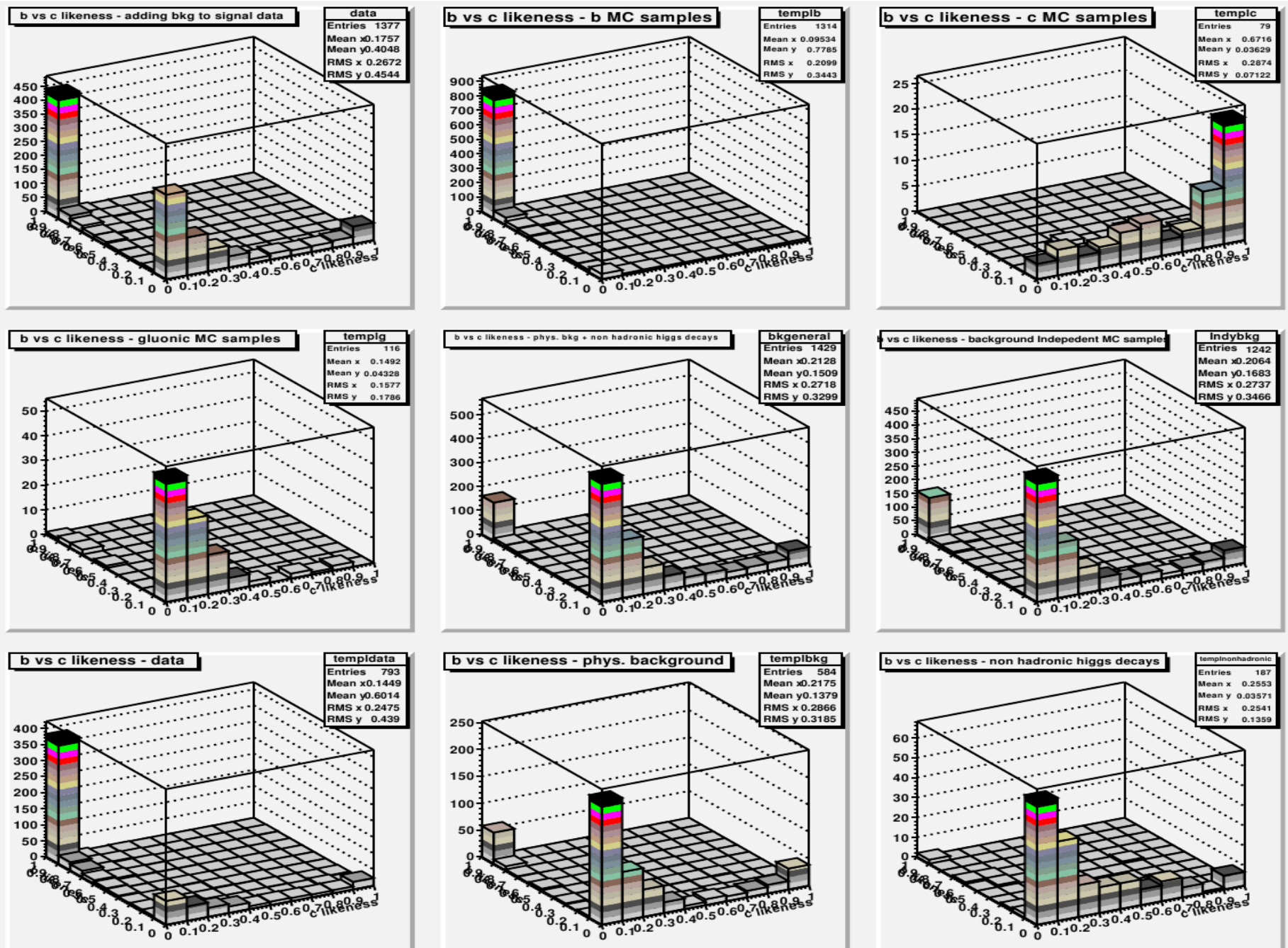


- Similar study but now with salt n' pepper background superimposed according to layer's r.o. time
- $\sim 250\text{fb}^{-1}$ of Higgsstrahlung analyzed
- In order to gain processing time silicon tracking modified
 - ✓ Negligible effect on the performance
- Better performance for double layers geometry
- Maybe consequence of tracking
 - $\sim 1\text{k}$ silicon tracks/evt for DL geometry
 - $\sim 5\text{k}$ silicon tracks /evt for SL geometry
 - $\sim 30/\text{evt}$ for both geometries w/o beam background

Higgs branching ratios extraction

- Based on ILD Letter Of Intent $ZH \rightarrow llq\bar{q}$ branching ratios analysis
 - Repeat these studies for different VXD geometries
 - Include beam background
- b(c) likeness: event wise variable
 - Likeness = $x_1x_2/(x_1x_2 + (1-x_1)(1-x_2))$, where $x_{1,2}$ are the outputs of the neural nets for first and second jet respectively
- Previous studies shown that a cut based extraction of the flavours does not yield the best sensitivity
- Use of template fitting technique
- There is no analytic distribution function so we use MC samples for the fitting
 - Split the initial sample to “data” and monte carlo
 - Split the monte carlo sample to $H \rightarrow b\bar{b}$, $H \rightarrow c\bar{c}$, $H \rightarrow g\bar{g}$, non hadronic higgs decays + physics background
 - Create 2D templates with b-c likeness and fit the data by changing the normalisations of each sample – fix bkg sample factor to 1
 - Extract branching ratios from the normalisation factors

MC templates for VXD05 - 500fb⁻¹



Fitting results

- $BR(H \rightarrow xx) = r_{xx} \times BR(H \rightarrow xx)_{SM}$, where r_{xx} are the fit results for each hadronic decay channel (bb,cc,gg) – these factors expected to be 1 for SM
- Comparison between relative errors for the candidate models – especially for c-tagging

	Double layers	Single layers
r_{bb}	0.93 \pm 0.06	0.99 \pm 0.06
r_{cc}	0.93 \pm 0.59	0.86 \pm 0.54
r_{gg}	1.68 \pm 0.58	0.88 \pm 0.61

Fit Limitations

- › Statistical fluctuation of MC samples
 - › Bins with very few events
 - › Templates with the majority of events at only 1 bin
- Trying different fitting methods
 - › Finally choose χ^2 mostly due to low statistics of MC templates

$$\chi^2 = \sum_{\text{bins}} (D_{\text{bins}} - (N_D / N_{MC}) \sum_s r_s N_s^{\text{bins}})^2 / \sigma_{\text{bins}}^2$$

- › χ^2 (cope with limited data but not with very few evts @ 1 bin) – cut at bins with <5 entries

Conclusions

- A vertex detector for ILC
 - Extract Higgs branching ratios – measure Higgs couplings
 - Reconstruct vertex charge: forward – backward asymmetry
- Impact parameter resolution figure of merit
 - Excellent heavy flavour tagging
 - High tracking capabilities (especially for low P_T tracks)
- Beamstrahlung is a big challenge for ILC VXD
- CMOS is a promising candidate technology for ILC VXD sensors
 - Exploit feature technology to trade off with the often conflicting ILD VXD requirements